# imall

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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





# AOW12N50/AOWF12N50

500V, 12A N-Channel MOSFET

General Description			Product Summary			
The AOW12N50 & AOWF12N50 have been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications.By providing low $R_{DS(on)}$ , $C_{iss}$ and $C_{rss}$ along with guaranteed avalanche			$V_{DS}$ I <sub>D</sub> (at V <sub>GS</sub> =10V) R <sub>DS(ON)</sub> (at V <sub>GS</sub> =10V)		600V@150℃ 12A < 0.52Ω	
	ts can be adopted quicl power supply designs.	kly into new	100% UIS Tested 100%  R <sub>g</sub> Tested	Green		
ТО	0-262	тс	D-262F			
Top View Bottom View		Top View	Bottom View			
				<u> </u>		
G Absolute Maximum	Batings Ta=25°C unle	ess otherwise no	G D S S D G	G	o s	
		ess otherwise no	G D S D		Units	
Parameter	Ratings T <sub>A</sub> =25°C unle		G D S D	AOWF12N50		
G Absolute Maximum Parameter Drain-Source Voltage Gate-Source Voltage	Ratings T <sub>A</sub> =25°C unle	Symbol	G D S D oted AOW12N50	<b>AOWF12N50</b>	Units	
Parameter Drain-Source Voltage	Ratings T <sub>A</sub> =25°C unle	Symbol V <sub>DS</sub> V <sub>GS</sub>	G D S D oted AOW12N50 50	<b>AOWF12N50</b>	Units V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$	Symbol V <sub>DS</sub>	G D S D oted AOW12N50 50 ±3	AOWF12N50	Units V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$	Symbol V <sub>DS</sub> V <sub>GS</sub>	G D S D oted AOW12N50 50 ±3 12	AOWF12N50 00 30 12* 8.4*	Units V V	
Parameter Drain-Source Voltage Bate-Source Voltage Continuous Drain Current Pulsed Drain Current Walanche Current <sup>C</sup>	<b>Ratings</b> $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$	Symbol           V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub>	G D S D oted AOW12N50 50 ±3 12 8.4	AOWF12N50 00 30 12* 8.4* 8	Units V V	
Parameter Drain-Source Voltage Bate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current <sup>C</sup> Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ energy $C$	Symbol           V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub>	G D S D oted AOW12N50 50 ±3 12 8.4 4	AOWF12N50 00 30 12* 8.4* 8 5	Units V V A	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current <sup>C</sup> Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ energy $C$	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AR</sub>	G D S D oted AOW12N50 ±3 12 8.4 4 5.	AOWF12N50 00 30 12* 8.4* 8 5 54	Units V V A A	
Parameter Drain-Source Voltage Gate-Source Voltage	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy $C$ che energy $G$ dv/dt	Symbol           V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>AR</sub> E <sub>AR</sub>	G D S D oted AOW12N50 50 ±3 12 8.4 4 5. 45 90 50	AOWF12N50 00 30 12* 8.4* 8 5 5 5 4 08 5	Units V V A A mJ	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current <sup>C</sup> Repetitive avalanche Single plused avalance Peak diode recovery of	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy c che energy c dv/dt $T_C=25^{\circ}C$	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AR</sub> E <sub>AR</sub> E <sub>AS</sub> dv/dt	G D S D oted AOW12N50 ±3 12 8.4 4 5 45 90	AOWF12N50 00 30 12* 8.4* 8 5 5 5 4 08	Units V V A A M M M J V/ns W	
Parameter Drain-Source Voltage Date-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current <sup>C</sup> Repetitive avalanche Single plused avalance Peak diode recovery of Power Dissipation <sup>B</sup>	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy $C$ c c dv/dt $T_C=25^{\circ}C$ Derate above $25^{\circ}C$	Symbol           V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AR</sub> E <sub>AR</sub> E <sub>AS</sub> dv/dt           P <sub>D</sub>	G D S D oted AOW12N50 ±3 12 8.4 4 5 45 90 5 5 250 2	AOWF12N50 00 30 12* 8.4* 8 5 5 5 5 4 08 5 5 28 0.22	Units V V A A M M M J V/ns V/ns W W/ °C	
Parameter Drain-Source Voltage Date-Source Voltage Continuous Drain Current Pulsed Drain Current Valanche Current <sup>C</sup> Repetitive avalanche Single plused avalance Pack diode recovery of Power Dissipation <sup>B</sup> unction and Storage	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy $C$ che energy $C$ che energy $C$ dv/dt $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AR</sub> E <sub>AR</sub> E <sub>AS</sub> dv/dt	G D S D oted AOW12N50 ±3 12 8.4 4 5. 45 90 5250	AOWF12N50 00 30 12* 8.4* 8 5 5 5 5 4 08 5 5 28 0.22	Units V V A A M M J W/ns W	
Parameter Drain-Source Voltage Date-Source Voltage Continuous Drain Current Pulsed Drain Current Valanche Current <sup>C</sup> Repetitive avalanche Single plused avalanche Single plused avalanche Deak diode recovery of Power Dissipation <sup>B</sup> unction and Storage Maximum lead tempe	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy $C$ c c dv/dt $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range rature for soldering	Symbol $V_{DS}$ $V_{GS}$ $I_D$ $I_{DM}$ $I_{AR}$ $E_{AR}$ $E_{AS}$ $dv/dt$ $P_D$ $T_J, T_{STG}$	G D S S D oted AOW12N50 50 ±3 12 8.4 4 5 45 90 5250 2 -55 to	AOWF12N50 00 30 12* 8.4* 8 5 5 5 28 0.22 0 150	Units V V A A MJ MJ V/ns W W/ °C °C	
Parameter Drain-Source Voltage Date-Source Voltage Continuous Drain Current Pulsed Drain Current Valanche Current Repetitive avalanche Single plused avalance Peak diode recovery of Power Dissipation <sup>B</sup> unction and Storage Maximum lead tempe purpose, 1/8" from ca	Ratings $T_A=25^{\circ}C$ unle $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy $C$ c dv/dt $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range rature for soldering se for 5 seconds	Symbol           V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AR</sub> E <sub>AR</sub> E <sub>AS</sub> dv/dt           P <sub>D</sub>	G D S S D oted AOW12N50 50 ±3 12 8.4 4 5 45 90 5250 2 -55 to	AOWF12N50 00 30 12* 8.4* 8 5 5 5 5 4 08 5 5 28 0.22	Units V V A A MJ MJ V/ns V/ns W W/ °C	
Parameter Drain-Source Voltage Date-Source Voltage Continuous Drain Current Pulsed Drain Current Valanche Current <sup>C</sup> Repetitive avalanche Single plused avalanche Single plused avalanche Power Dissipation <sup>B</sup> Unction and Storage Maximum lead tempe Urpose, 1/8" from ca Thermal Characteris	Ratings $T_A=25^{\circ}C$ unlest $T_C=25^{\circ}C$ $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ C energy $C$ the energy $C$ $T_C=25^{\circ}C$ Derate above 25 $^{\circ}C$ Temperature Range rature for soldering se for 5 seconds stics	Symbol $V_{DS}$ $V_{GS}$ $I_D$ $I_{DM}$ $I_{AR}$ $E_{AR}$ $E_{AS}$ $dv/dt$ $P_D$ $T_J, T_{STG}$ $T_L$	G D S D oted AOW12N50 50 ±3 12 8.4 4 5 45 90 50 250 2 -55 to 30	AOWF12N50 00 30 12* 8.4* 8 5 5 5 28 0.22 0 150 00	Units V V A A MJ MJ V/ns W W/ °C C °C	
Parameter Drain-Source Voltage Date-Source Voltage Continuous Drain Current Pulsed Drain Current Valanche Current <sup>C</sup> Repetitive avalanche Single plused avalanche Single plused avalanche Power Dissipation <sup>B</sup> unction and Storage Maximum lead tempe purpose, 1/8" from ca Thermal Characteris	Ratings $T_A=25^{\circ}C$ unlest $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ C energy $C$ the energy $G$ dv/dt $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range rature for soldering se for 5 seconds stics rameter	Symbol V <sub>DS</sub> V <sub>GS</sub> I <sub>D</sub> I <sub>DM</sub> I <sub>AR</sub> E <sub>AR</sub> E <sub>AS</sub> dv/dt P <sub>D</sub> T <sub>J</sub> , T <sub>STG</sub> T <sub>L</sub> Symbol	G D S S D oted AOW12N50 50 ±3 12 8.4 4 5 45 90 5250 2 -55 to	AOWF12N50 00 30 12* 8.4* 8 5 5 5 28 0.22 0 150	Units V V A A MJ MJ V/ns W W/ °C °C	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current <sup>C</sup> Repetitive avalanche Single plused avalanche Single plused avalanche Power Dissipation <sup>B</sup> unction and Storage Maximum lead tempe purpose, 1/8" from ca Thermal Characteris	Ratings $T_A=25^{\circ}C$ unlest $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ C $T_C=100^{\circ}C$ $T_C=25^{\circ}C$ Derate above 25^{\circ}C Temperature Range rature for soldering se for 5 seconds stics rameter -Ambient <sup>A,D</sup>	Symbol $V_{DS}$ $V_{GS}$ $I_D$ $I_{DM}$ $I_{AR}$ $E_{AR}$ $E_{AS}$ $dv/dt$ $P_D$ $T_J, T_{STG}$ $T_L$	G D S D oted AOW12N50 ±3 12 8.4 4 5. 45 90 250 2 250 2 -55 to 30 AOW12N50	AOWF12N50 00 30 12* 8.4* 8 5 5 5 6 4 08 5 28 0.22 0 150 00 AOWF12N50	Units V V A A MJ MJ V/ns W W/ °C °C °C Units	

\* Drain current limited by maximum junction temperature.



### Electrical Characteristics (TJ=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	500				
		$I_D$ =250µA, $V_{GS}$ =0V, $T_J$ =150°C		600		V	
BV <sub>DSS</sub> /∆TJ	Zero Gate Voltage Drain Current	ID=250μΑ, VGS=0V		0.54		V/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =500V, V <sub>GS</sub> =0V			1	μA	
		V <sub>DS</sub> =400V, T <sub>J</sub> =125°C			10	μΛ	
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±30V			±100	nA	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}$ =5V $I_D$ =250 $\mu$ A	3.3	3.9	4.5	V	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =6A		0.36	0.52	Ω	
<b>g</b> fs	Forward Transconductance	$V_{DS}$ =40V, $I_{D}$ =6A		16		S	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.72	1	V	
I <sub>S</sub>	Maximum Body-Diode Continuous Current				12	Α	
I <sub>SM</sub>	Maximum Body-Diode Pulsed Current				48	Α	
DYNAMI	C PARAMETERS						
C <sub>iss</sub>	Input Capacitance		1089	1361	1633	pF	
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz	115	167	218	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance		7	12.6	18	pF	
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	1.8	3.6	5.4	Ω	
SWITCHI	NG PARAMETERS						
Qg	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =400V, I <sub>D</sub> =12A	24	30.7	37	nC	
$Q_{gs}$	Gate Source Charge		6	7.6	9	nC	
$Q_{gd}$	Gate Drain Charge		6	13.0	20	nC	
t <sub>D(on)</sub>	Turn-On DelayTime			29	35	ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =250V, $I_{D}$ =12A,		69	83	ns	
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_G=25\Omega$		82	98	ns	
t <sub>f</sub>	Turn-Off Fall Time			55.5	67	ns	
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =12A,dI/dt=100A/μs,V <sub>DS</sub> =100V	180	231	277	ns	
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	e I <sub>F</sub> =12A,dI/dt=100A/μs,V <sub>DS</sub> =100V	2.2	2.82	3.4	μC	

A. The value of R  $_{0JA}$  is measured with the device in a still air environment with T  $_A$  =25°C.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C, Ratings are based on low frequency and duty cycles to keep initial  $T_J$ =25°C.

D. The R  $_{0JA}$  is the sum of the thermal impedence from junction to case R  $_{0JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300  $\mu$ s pulses, duty cycle 0.5% max.

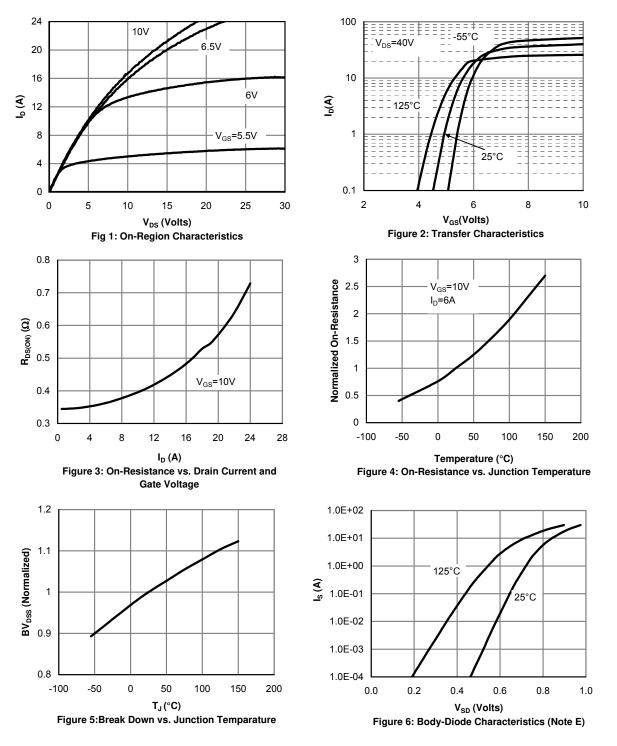
F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150°C. The SOA curve provides a single pulse rating.

G. L=60mH,  $I_{AS}$ =5.5A,  $V_{DD}$ =150V,  $R_{G}$ =25 $\Omega$ , Starting  $T_{J}$ =25°C

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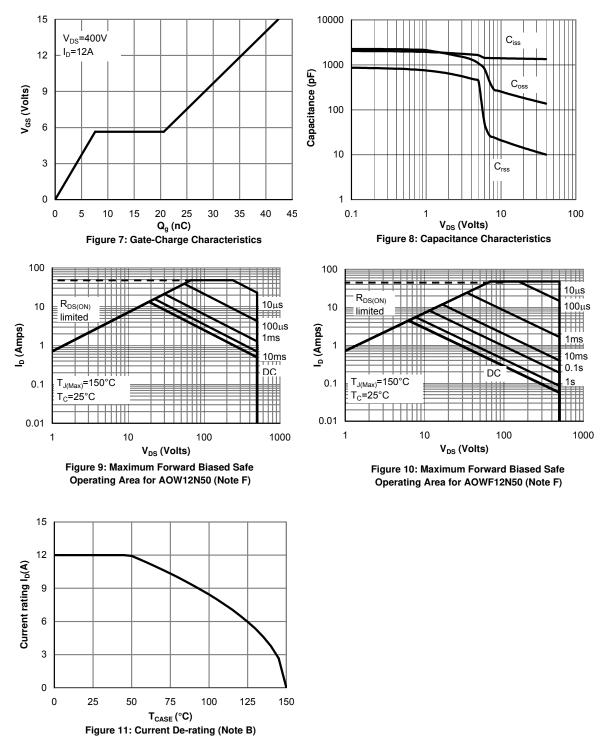


## **TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**





# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





### **TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

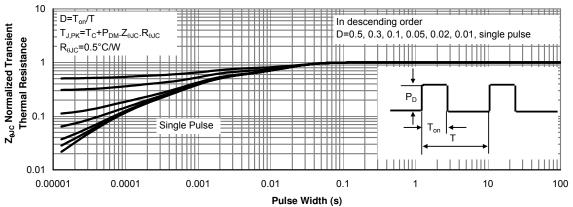


Figure 12: Normalized Maximum Transient Thermal Impedance for AOW12N50 (Note F)

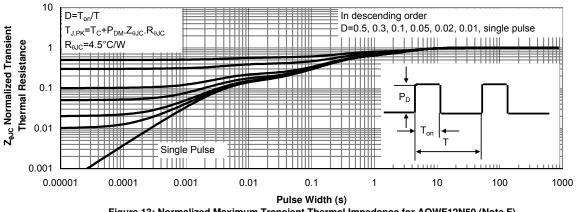


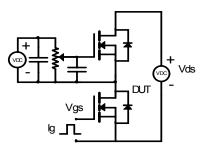
Figure 13: Normalized Maximum Transient Thermal Impedance for AOWF12N50 (Note F)

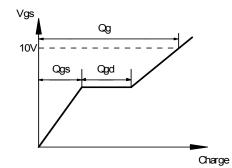
90%

10%

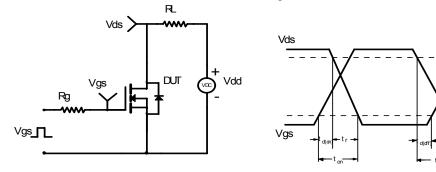


### Gate Charge Test Circuit & Waveform

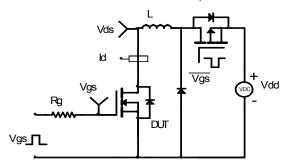


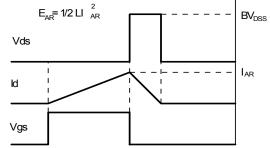


Resistive Switching Test Circuit & Waveforms

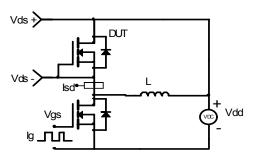


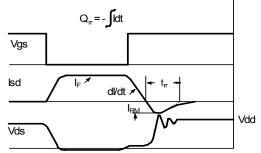
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





#### Diode Recovery Test Circuit & Waveforms





Rev0: June 2010